

<b>Notice of References Cited</b>	Application/Control No. 10/059,238	Applicant(s)/Patent Under Reexamination ONO, KENICHI	
	Examiner Hai C. Pham	Art Unit 2861	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,445,404	09-2002	Kerby et al.	347/237
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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